


<b>Search Notes</b>  	<b>Application/Control No.</b>  10599531	<b>Applicant(s)/Patent Under Reexamination</b>  LIU, SHENG
	<b>Examiner</b>  ANKUR JAIN	<b>Art Unit</b>  2618

SEARCHED			
Class	Subclass	Date	Examiner
455	522	12/8/2008	AJ

SEARCH NOTES		
Search Notes	Date	Examiner
Searched databases USPAT, US-PGPUB, EPO, JPO, DERWENT, and IBM_TDB. EAST Search History is attached.	12/8/2008	AJ

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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